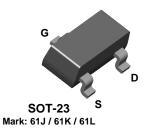


PN4091 PN4092 PN4093 MMBF4091 MMBF4092 **MMBF4093**





NOTE: Source & Drain are interchangeable

N-Channel Switch

This device is designed for low level analog switching, sample and hold circuits and chopper stabalized amplifiers. Sourced from Process 51. See J111 for characteristics.

Absolute Maximum Ratings*

TA = 25°C unless otherwise noted

Symbol	Parameter	Value	Units
V_{DG}	Drain-Gate Voltage	40	V
V _{GS}	Gate-Source Voltage	- 40	V
I _{GF}	Forward Gate Current	50	mA
T_J , T_stg	Operating and Storage Junction Temperature Range	-55 to +150	°C

^{*}These ratings are limiting values above which the serviceability of any semiconductor device may be impaired.

Thermal Characteristics TA = 25°C unless otherwise noted

Symbol	Characteristic	Max		Units
		PN4091-4093	*MMBF4091-4093	
P _D	Total Device Dissipation Derate above 25°C	625 5.0	350 2.8	mW mW/°C
$R_{\theta JC}$	Thermal Resistance, Junction to Case	125	0	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction to Ambient	357	556	°C/W

^{*}Device mounted on FR-4 PCB 1.6" X 1.6" X 0.06."

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¹⁾ These ratings are based on a maximum junction temperature of 150 degrees C.

2) These are steady state limits. The factory should be consulted on applications involving pulsed or low duty cycle operations

N-Channel Switch

(continued)

Symbol	Parameter	Test Conditions	Min	Max	Units
OFF CHAF	RACTERISTICS				
V _{(BR)GSS}	Gate-Source Breakdown Voltage	$I_G = 1.0 \mu A, V_{DS} = 0$	- 40		V
V _{GS(off)}	Gate-Source Cutoff Voltage	, ,	91 - 5.0	- 10	V
		-	92 - 2.0 93 - 1.0	- 7.0 - 5.0	V
I _{DGO}	Drain-Gate Leakage Current	V _{DG} = 20 V, I _S = 0 V _{DG} = 20 V, I _S = 0, T _A = 150°C		- 200 - 400	pA nA
I _{D(off)}	Drain Cutoff Leakage Current	$V_{DS} = 20 \text{ V}, V_{GS} = -12 \text{ V}$ 40	91	200	рA
		,	92 93	200 200	pA pA
		$V_{DS} = 20 \text{ V}, V_{GS} = -12 \text{ V},$	91	400	nA
		$V_{DS} = 20 \text{ V}, V_{GS} = -8.0 \text{ V},$	92	400	nA
		$V_{DS} = 20 \text{ V}, V_{GS} = -6.0 \text{ V},$ $T_A = 150^{\circ}\text{C}$ 40	93	400	nA
V _{DS(on)}	Drain-Source On Voltage Drain-Source On Resistance	$\begin{array}{c} & & \textbf{40} \\ I_D = 6.6 \text{ mA}, V_{GS} = 0 & \textbf{40} \\ I_D = 4.0 \text{ mA}, V_{GS} = 0 & \textbf{40} \\ I_D = 2.5 \text{ mA}, V_{GS} = 0 & \textbf{40} \\ I_D = 1.0 \text{ mA}, V_{GS} = 0 & \textbf{40} \end{array}$	92 15 93 8.0 91 92 93 91 92	0.2 0.2 0.2 0.2 30 50	mA mA V V V
		_	93	80	Ω
SMALL-SI	GNAL CHARACTERISTICS				
r _{ds(on)}	Drain-Source On Resistance	40	91 92 93	30 50 80	Ω
C _{iss}	Input Capacitance	$V_{DS} = 20, V_{GS} = 0, f = 1.0 \text{ MHz}$	193	16	Ω pF
Crss	Reverse Transfer Capacitance	V _{GS} = - 20 V, f = 1.0 MHz		5.0	pF
SWITCHII	NG CHARACTERISTICS			1	
t _{on}	Turn-On Time		91	25 35	ns
		_(-,-,	192 193	60	ns ns
t _{off}	Turn-Off Time		91	40	ns
		$V_{GS(off)} = 6.0 \text{ V}$ 40	92	60	ns
	1	$V_{GS(off)} = 3.0 \text{ V}$ 40	93	80	ns

^{*}Pulse Test: Pulse Width \leq 300 μ s, Duty Cycle \leq 1.0%

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Rev. G